

**MSCSM120AM08CT3G**  
**Datasheet**  
**Phase Leg SiC MOSFET Power Module**

January 2020



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# 1 Revision History

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The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

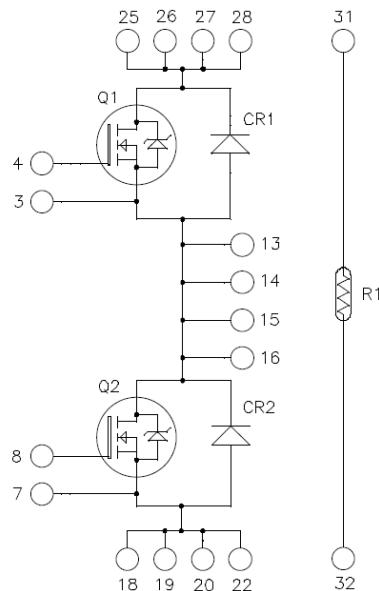
## 1.1 Revision 1.0

Revision 1.0 is the first publication of this document, published in January 2020.

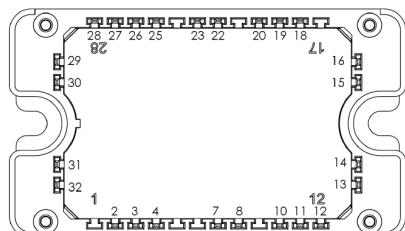
## 2 Product Overview

The MSCSM120AM08CT3AG is a phase leg 1200 V/337 A full silicon carbide power module.

**Figure 1 • MSCSM120AM08CT3AG Electrical Schematic**



**Figure 2 • MSCSM120AM08CT3AG Pinout Location**



Pins 25 to 28 must be shorted together  
Pins 13 to 16 must be shorted together  
Pins 18/19/20/22 must be shorted together

All ratings at  $T_J = 25^\circ\text{C}$  unless otherwise specified.

**Caution:** These devices are sensitive to electrostatic discharge. Proper handling procedures should be followed.

## 2.1 Features

The following are key features of the MSCSM120AM08CT3AG device:

- SiC Power MOSFET
  - High-speed switching
  - Low RDS(on)
  - Ultra low loss
- Silicon carbide (SiC) Schottky diode
  - Zero reverse recovery
  - Zero forward recovery
  - Temperature-independent switching behavior
  - Positive temperature coefficient on VF
- Low stray inductance
- Kelvin source for easy drive
- Internal thermistor for temperature monitoring
- Aluminum nitride (AlN) substrate for improved thermal performance

## 2.2 Benefits

The following are benefits of the MSCSM120AM08CT3AG device:

- High efficiency converter
- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction-to-case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

## 2.3 Applications

The MSCSM120AM08CT3AG device is designed for the following applications:

- Inductor heating and welding
- Solar inverter
- EV motor and traction drive

## 3 Electrical Specifications

This section shows the specifications of the MSCSM120AM08CT3AG device.

### 3.1 SiC MOSFET Characteristics (Per MOSFET)

This section describes the electrical characteristics of the MSCSM120AM08CT3AG device.

**Table 1 • Absolute Maximum Ratings**

Symbol	Parameter	Maximum Ratings		Unit
$V_{DSS}$	Drain-source voltage	1200		V
$I_D$	Continuous drain current	$T_C = 25\text{ }^\circ\text{C}$	337 <sup>1</sup>	A
		$T_C = 80\text{ }^\circ\text{C}$	268 <sup>1</sup>	
$I_{DM}$	Pulsed drain current	675		
$V_{GS}$	Gate-source voltage	-10/25		V
$R_{DSon}$	Drain-source ON resistance	7.8		$\text{m}\Omega$
$P_D$	Power dissipation	$T_C = 25\text{ }^\circ\text{C}$	1409	W

**Note:**

1. Specification of SiC MOSFET device but output current must be limited due to size of power connectors.

**Table 2 • Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{DSS}$	Zero gate voltage drain current	$V_{GS} = 0\text{ V}$ ; $V_{DS} = 1200\text{ V}$		40	400		$\mu\text{A}$
$R_{DSon}$	Drain–source on resistance	$V_{GS} = 20\text{ V}$ $I_D = 160\text{ A}$	$T_J = 25\text{ }^\circ\text{C}$	6.3	7.8		$\text{m}\Omega$
			$T_J = 175\text{ }^\circ\text{C}$		10		
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{GS} = V_{DS}$ , $I_D = 4\text{ mA}$		1.8	2.8		V
$I_{GSS}$	Gate–source leakage current	$V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$				400	nA

**Table 3 • Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{iss}$	Input capacitance	$V_{GS} = 0 \text{ V}$ $V_{DS} = 1000 \text{ V}$ $f = 1 \text{ MHz}$		12.08		pF
$C_{oss}$	Output capacitance			1		
$C_{rss}$	Reverse transfer capacitance			0.1		
$Q_g$	Total gate charge	$V_{GS} = -5/20 \text{ V}$ $V_{Bus} = 800 \text{ V}$ $I_D = 160 \text{ A}$		928		nC
$Q_{gs}$	Gate–source charge			164		
$Q_{gd}$	Gate–drain charge			200		
$T_{d(on)}$	Turn-on delay time	$V_{GS} = -5/20 \text{ V}$ $V_{Bus} = 600 \text{ V}$ $I_D = 200 \text{ A}$ $R_{Gon} = 2\Omega$ ; $R_{Goff} = 1.2\Omega$		30		ns
$T_r$	Rise time			30		
$T_{d(off)}$	Turn-off delay time			50		
$T_f$	Fall time			25		
$E_{on}$	Turn on energy	$V_{GS} = -5/20 \text{ V}$ $V_{Bus} = 600 \text{ V}$ $I_D = 200 \text{ A}$ $R_{Gon} = 2\Omega$ $R_{Goff} = 1.2\Omega$	$T_J = 150 \text{ }^\circ\text{C}$	4		mJ
$E_{off}$	Turn off energy		$T_J = 150 \text{ }^\circ\text{C}$	2.6		
$R_{Gint}$	Internal gate resistance			1.5		$\Omega$
$R_{thJC}$	Junction-to-case thermal resistance				0.106	$^\circ\text{C}/\text{W}$

**Table 4 • Body Diode Ratings and Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$V_{SD}$	Diode forward voltage	$V_{GS} = 0 \text{ V}$ ; $I_{SD} = 160 \text{ A}$		4		V
		$V_{GS} = -5 \text{ V}$ ; $I_{SD} = 160 \text{ A}$		4.2		
$t_{rr}$	Reverse recovery time	$I_{SD} = 160 \text{ A}$ ; $V_{GS} = -5 \text{ V}$ ; $V_R = 800 \text{ V}$ $dI/dt = 4000 \text{ A}/\mu\text{s}$		90		ns
$Q_{rr}$	Reverse recovery charge			2200		
$I_{rr}$	Reverse recovery current			54		A

### 3.2

### Reverse SiC Diode Ratings and Characteristics (Per SiC Diode)

The following section shows the reverse SiC diode ratings and characteristics per diode of the device.

**Table 5 • Reverse SiC Diode Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_{RRM}$	Peak repetitive reverse voltage					1200	V
$I_{RRM}$	Reverse leakage current	$V_R = 1200$ V	$T_J = 25$ °C		40	800	μA
			$T_J = 175$ °C			600	
$I_F$	DC forward current		$T_C = 100$ °C		120		A
$V_F$	Diode forward voltage	$I_F = 120$ A	$T_J = 25$ °C		1.5	1.8	V
			$T_J = 175$ °C			2.1	
$Q_C$	Total capacitive charge	$I_F = 120$ A			520		nC
$C$	Total capacitance	$f = 1$ MHz, $V_R = 400$ V			564		pF
		$f = 1$ MHz, $V_R = 800$ V				420	
$R_{thJC}$	Junction-to-case thermal resistance					0.252	°C/W

### 3.3

### Thermal and Package Characteristics

This section shows the thermal and package characteristics of the device.

**Table 6 • Package Characteristics**

Symbol	Characteristic			Min	Max	Unit
$V_{ISOL}$	RMS isolation voltage, any terminal to case $t = 1$ min, 50/60Hz			4000		V
$T_J$	Operating junction temperature range			-40	175	°C
$T_{JOP}$	Recommended junction temperature under switching conditions			-40	$T_{Jmax} - 25$	°C
$T_{STG}$	Storage temperature range			-40	125	°C
$T_C$	Operating case temperature			-40	125	°C
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package weight				110	g

**Table 7 • Temperature Sensor NTC<sup>1</sup>**

Symbol	Characteristic	Min	Typ	Max	Unit
R <sub>25</sub>	Resistance at 25 °C		50		kΩ
ΔR <sub>25</sub> /R <sub>25</sub>			5		%
B <sub>25/85</sub>	T <sub>25</sub> = 298.15 K		3952		K
ΔB/B		T <sub>C</sub> = 100 °C	4		%

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]} \quad T: \text{Thermistor temperature}$$

R<sub>T</sub>: Thermistor value at T

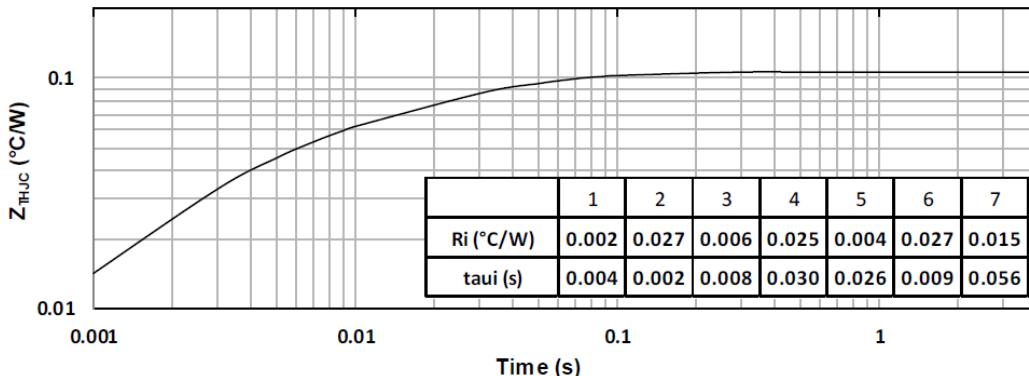
**Note:**

1. See application note APT0406 on [www.microsemi.com](http://www.microsemi.com).

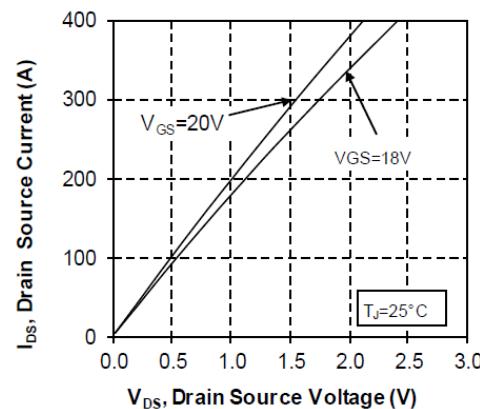
### 3.4 Typical SiC MOSFET Performance Curves

This section shows the typical performance curves of the MSCSM120AM08CT3AG SiC MOSFET.

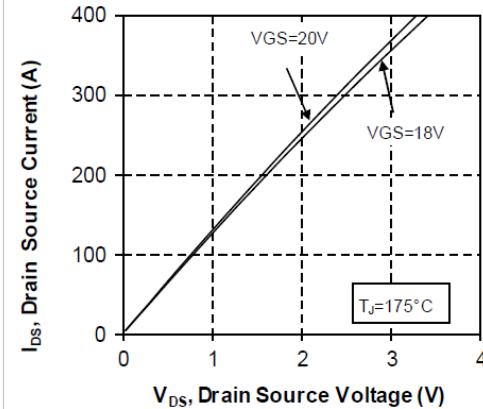
**Figure 3 • Maximum Thermal Impedance**



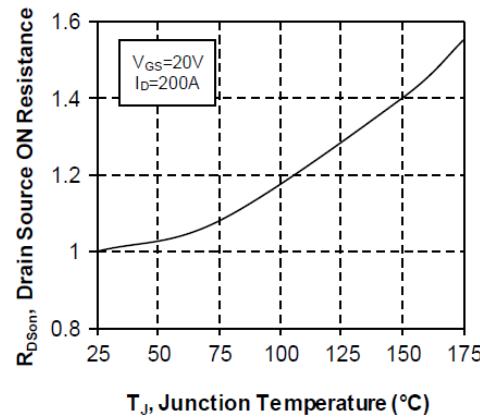
**Figure 4 • Output Characteristics,  $T_J = 25^{\circ}\text{C}$**



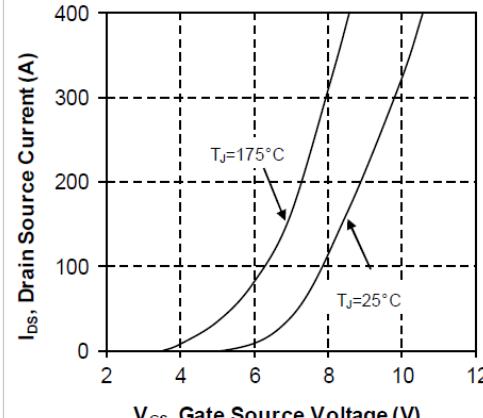
**Figure 5 • Output Characteristics,  $T_J = 175^{\circ}\text{C}$**

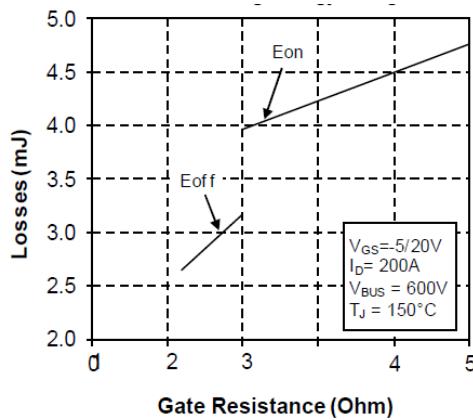
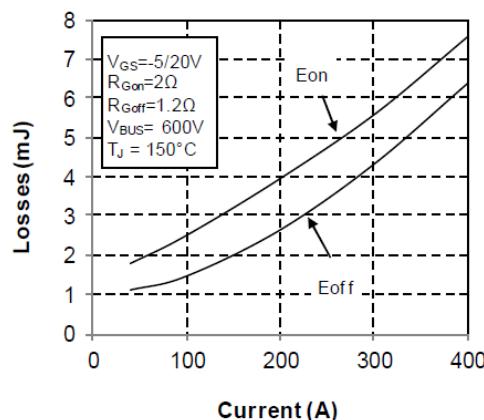
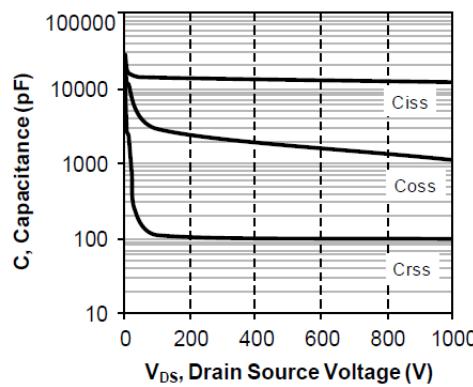
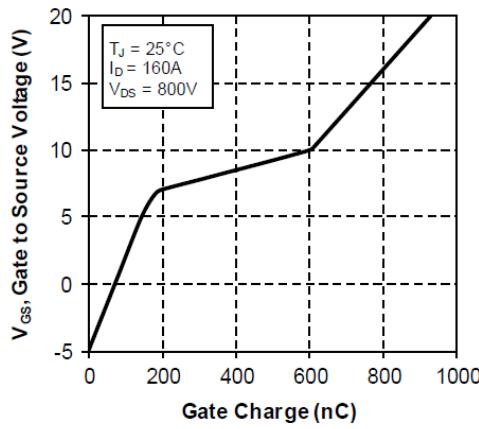
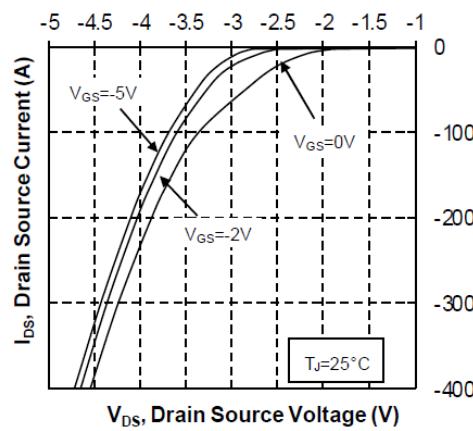
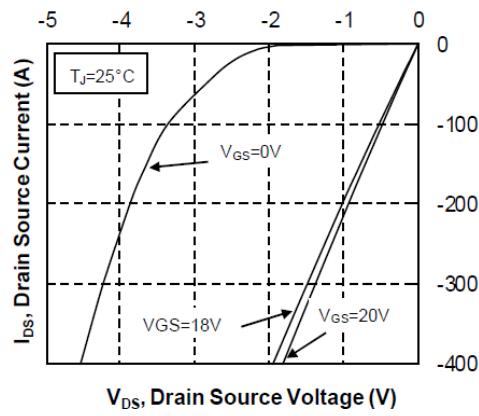


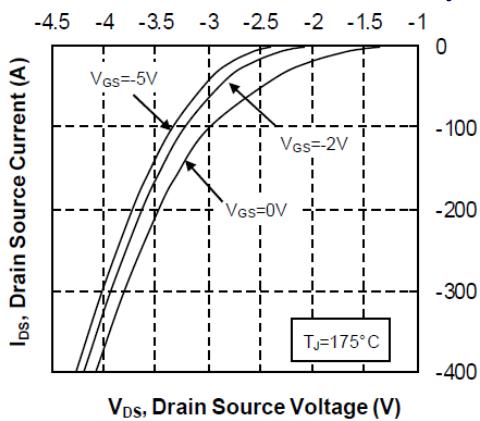
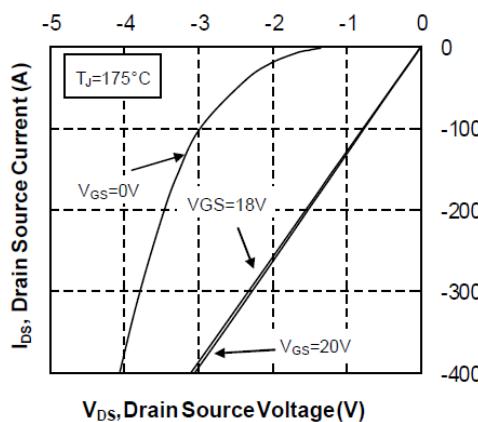
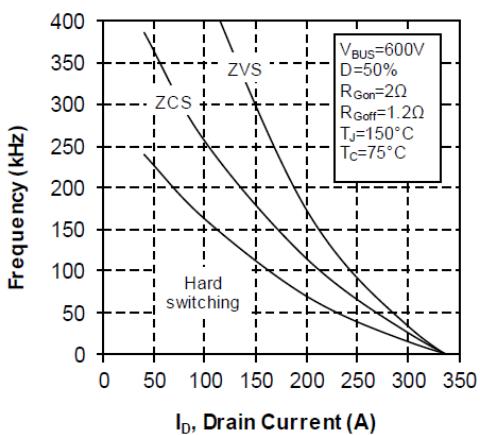
**Figure 6 • Normalized RDS(on) vs. Temperature**



**Figure 7 • Transfer Characteristics**



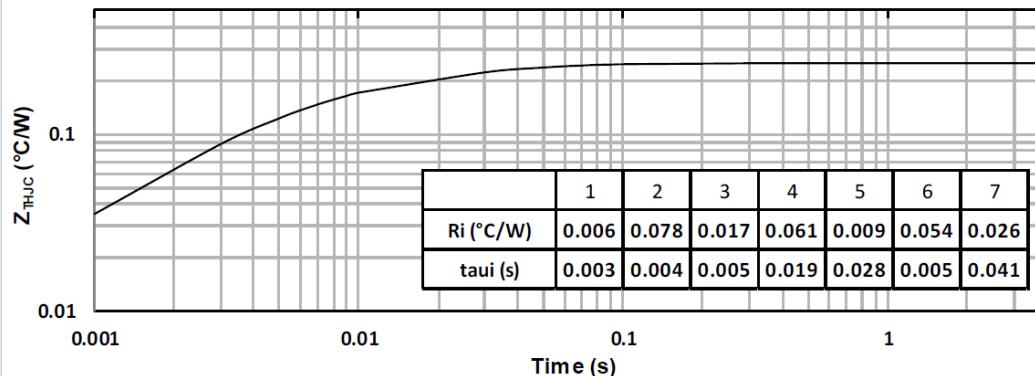
**Figure 8 • Switching Energy vs. R<sub>g</sub>****Figure 9 • Switching Energy vs. Current****Figure 10 • Capacitance vs. Drain Source Voltage****Figure 11 • Gate Charge vs. Gate Source Voltage****Figure 12 • Body Diode Characteristics,  $T_J = 25^{\circ}C$** **Figure 13 • 3<sup>rd</sup> Quadrant Characteristics,  $T_J = 25^{\circ}C$** 

**Figure 14 • Body Diode Characteristics,  $T_J = 175^\circ\text{C}$** **Figure 15 • 3<sup>rd</sup> Quadrant Characteristics,  $T_J = 175^\circ\text{C}$** **Figure 16 • Operating Frequency vs. Drain Current**

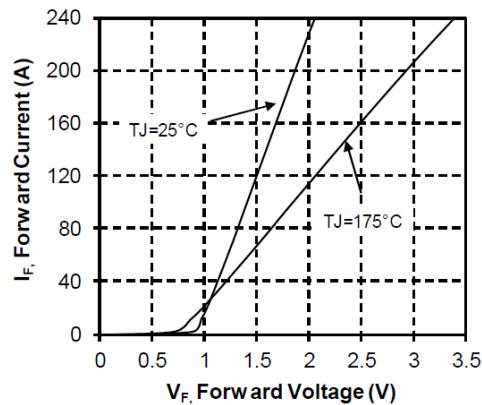
### 3.5 Typical SiC Diode Performance Curves

This section shows the typical performance curves of the MSCSM120AM08CT3AG SiC diode.

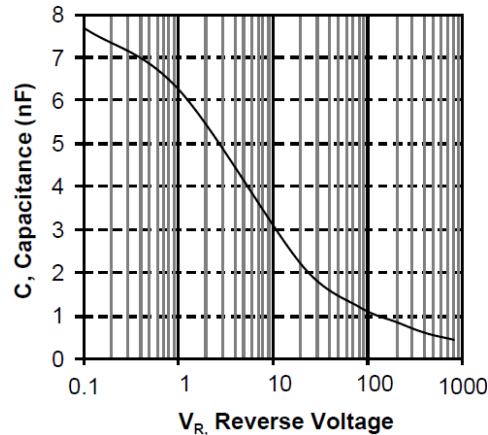
**Figure 17 • Maximum Thermal Impedance**



**Figure 18 • Forward Characteristics**



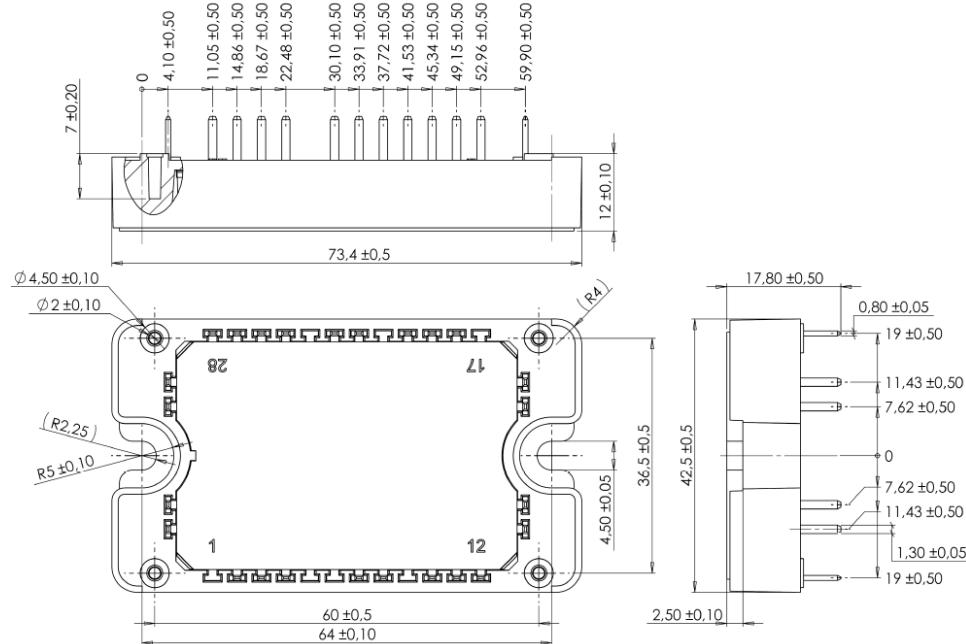
**Figure 19 • Capacitance vs. Reverse Voltage**



## 4 Package Specifications

This section shows the package outline of the MSCSM120AM08CT3AG device. All dimensions are in millimeters.

**Figure 20 • Package Outline**



See application note 1906 – Mounting Instructions for SP3F Power Modules on [www.microsemi.com](http://www.microsemi.com).



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